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### Simulation of the emitter existence conditions during cathode arc deposition of refractory materials

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The vacuum cathode arc deposition technology offer an excellent approach to production pure metal, alloy and compound at very high rates and with excellent adhesion and density. This allows efficient use of the method for applying coatings to accelerator technology [1]. However, there are problems with the choice of process parameters which will form a uniform film without dropping fraction [2]. Therefore, the use of modeling processes of the formation of the plasma is an urgent problem.

Significantly upgrading one-dimensional mathematical model [3], which took into account the dependence of the heat capacity and thermal conductivity on temperature [4], the finite element method calculated the temperature distribution along the height of the emitter at different values in vacuum-arc deposition of zirconium, titanium and titanium nitride on the substrate.

Calculated minimum temperature explosion ecton and his warm-up time before the explosion at the characteristic of the current density ( $1,2 \cdot 10^{12}$  A/m<sup>2</sup>), which makes up for titanium nitride  $t = 9.86$  ns at  $T = 6136$  K, for titanium  $t = 9.48$  ns at  $T = 7002$  K, for zirconium  $t = 9.04$  ns at  $T = 8336$  K (fig. 1).

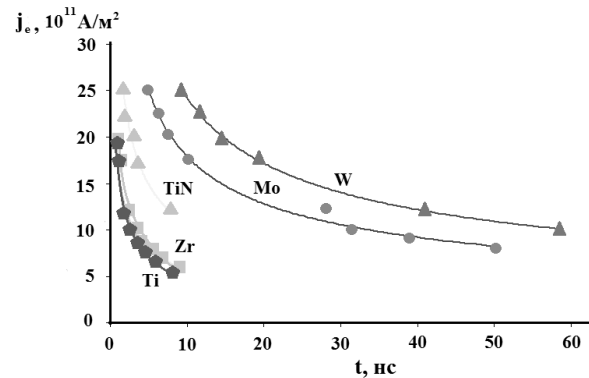


Fig. 1. Change the emitter heating time for different values of the emission current density.

The calculation in the model will improve the effectiveness of materials deposition by pre-determining the main technological parameters of sedimentation: current density, pulse discharge time, frequency UVH generation.

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